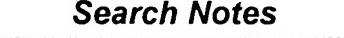


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/693,466	JANG ET AL.	
	Examiner Tianjie Chen	Art Unit 2656	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner